

Notice of References Cited	Application/Control No. 09/482,332		Applicant(s)/Patent Under Reexamination LAMSON ET AL.	
	Examiner Fred Ferris		Art Unit 2123	Page 1 of 2

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*	X	"Electrical Performance of High-Speed Interconnect Systems", M.R. Scheinfein et al, IEEE Transactions of components, Hybrids, and Manufacturing Technology, Vol. CHMT-10, No. 3, September 1987

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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	Examiner Fred Ferris	Art Unit 2123	Page 2 of 2

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